

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/609,633	WISNIEWSKI ET AL.	WISNIEWSKI ET AL.
Examiner	Art Unit	Art Unit
Khai M. Nguyen	2617	2617

SEAR	CHED	
Subclass	Date	Examiner
previous		KN
	Subclass	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (see attached)	10/25/2007	KN		
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